# EE788: Assignment 1

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All parts of the assignment are for an NMOS type transistor.

From the graph given, the following conditions are used in code for the 3 cases:

Case	$L (in \mu m)$	$t_{ox}$ (in nm)	$V_{DD}$ (in V)	$V_{th}$ (in V)
1	1	20	5	0.8
2	0.5	10	3.5	0.55
3	0.35	7	3	0.5

- For fixed mobility calculations,  $\mu_n = 200 cm^2/V \cdot s$  is used.
- For all the parts below, based on the  $V_{th}$  from the graph, the substrate concentration  $N_A$  is obtained via interpolation and used in further calculations.
- Width used is  $1\mu m$  for all calculations. For a width of  $W\mu m$ , the results obtained below would merely have to be scaled W times.
- For  $I_D V_D$  characteristics,  $V_G$  values of 2.5, 3.5 and 4.5 V are used
- For  $I_D V_G$  characteristics,  $V_D$  values of 0.5, 2 and 3.5 V are used

For the results of all 3 models,

- As  $t_{ox}$  and L decrease,  $C_{ox}$  and (W/L) increase, so current increases
- We see that the orders of current in all 3 models are almost identical (Pao-Sah gives a marginally higher value of current. Brews and Piecewise give equal currents)
- In the  $I_D V_G$  characteristics for Case 2 and 3, the curves for  $V_D = 2$  and 3.5V overlap.

## Piecewise Model

Depending on the region of operation, different equations of current are used. Here,  $V_{D,sat} = (V_{GS} - V_{th})/m$ 

Subthreshold region  $(V_{GS} < V_{th})$ :

$$I_D = \mu C_{ox} \left(\frac{W}{L}\right) (m-1) \left(\frac{kT}{q}\right)^2 e^{q(V_{GS} - V_{th})/mkT} \left(1 - e^{-qV_{DS}/kT}\right)$$

Linear region  $(V_{GS} \ge V_{th} \text{ and } V_{DS} < V_{D,sat})$ :

$$I_D = \mu C_{ox} \left(\frac{W}{L}\right) \left(V_{GS} - V_{th} - \frac{mV_{DS}}{2}\right) V_{DS}$$

Saturation region  $(V_{GS} \ge V_{th} \text{ and } V_{DS} \ge V_{D,\text{sat}})$ :

$$I_D = \mu C_{ox} \left(\frac{W}{L}\right) \frac{\left(V_{GS} - V_{th}\right)^2}{2m}$$

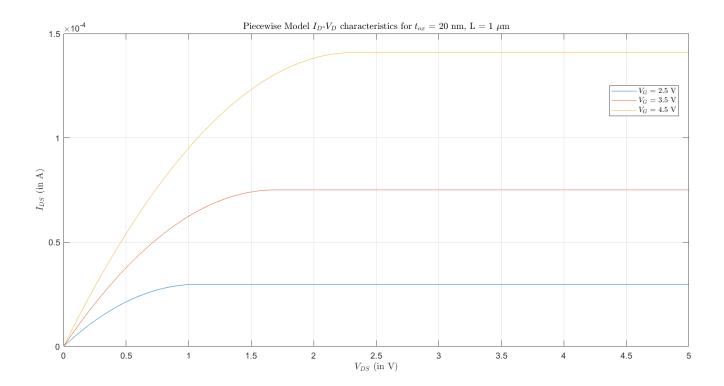


Figure 1: Case 1:  $I_D - V_D$  characteristics for Piecewise model

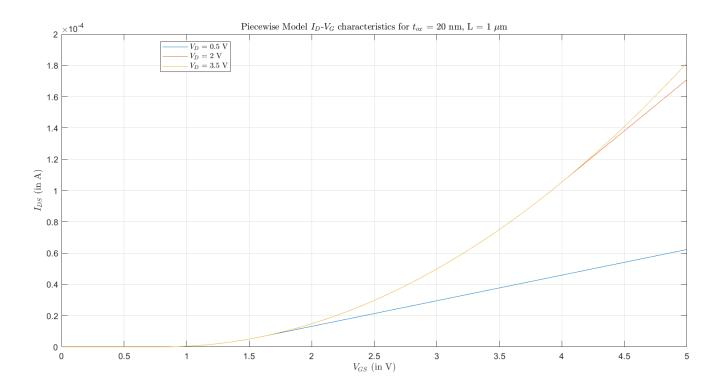


Figure 2: Case 1:  $I_D - V_G$  characteristics for Piecewise model

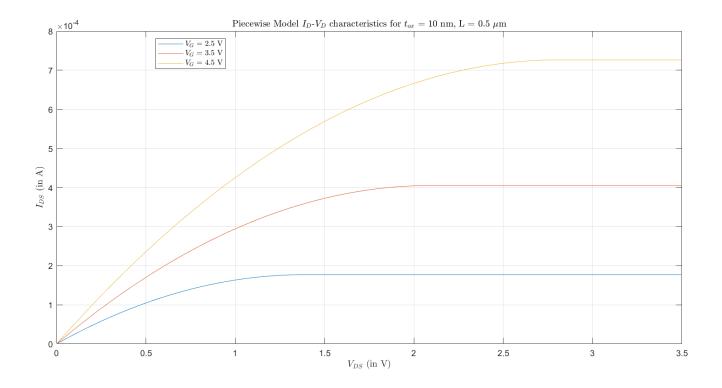


Figure 3: Case 2:  $I_D - V_D$  characteristics for Piecewise model

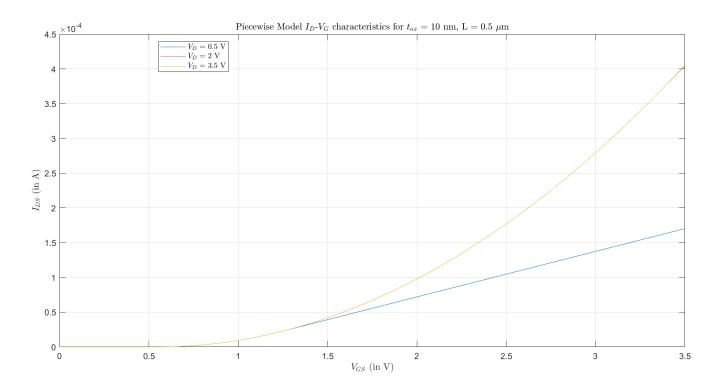


Figure 4: Case 2:  $I_D - V_G$  characteristics for Piecewise model

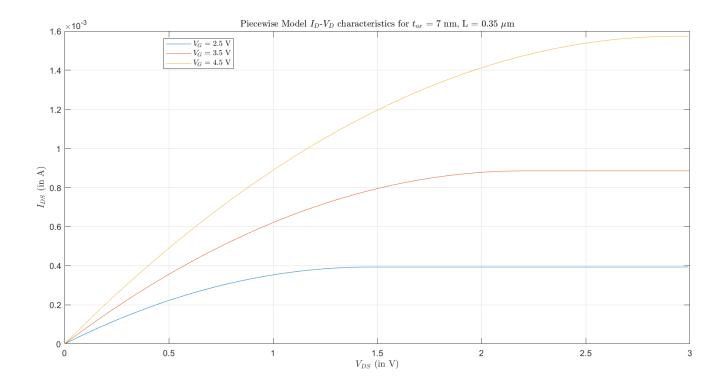


Figure 5: Case 3:  $I_D - V_D$  characteristics for Piecewise model

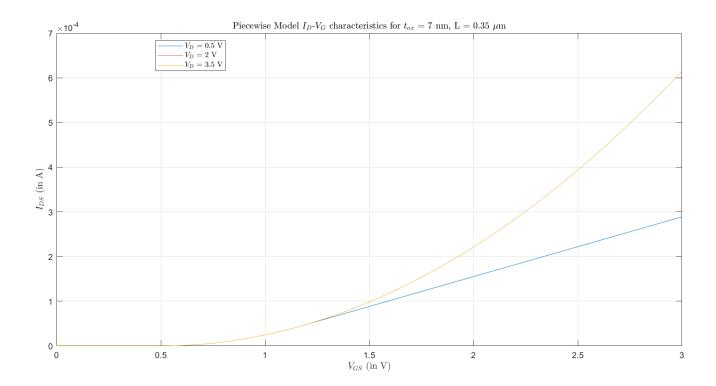


Figure 6: Case 3:  $I_D - V_G$  characteristics for Piecewise model

#### Pao-Sah Model

The following equations are used:

$$I_D = q\mu \left(\frac{W}{L}\right) \int_0^{V_{DS}} \left( \int_{\delta}^{\Psi_S} \frac{\frac{n_i^2}{N_A} e^{q(\Psi - V)/kT}}{-\frac{d\Psi}{dx}} d\Psi \right) dV$$
 (1)

$$-\frac{d\Psi}{dx} = \sqrt{\frac{2kTN_A}{\epsilon_{Si}} \left(\frac{q\Psi}{kT} + \frac{n_i^2}{N_A^2} e^{q(\Psi - V)/kT}\right)}$$
 (2)

$$V_{GS} = V_{FB} + \Psi_S + \frac{2\epsilon_{Si}kTN_A}{C_{ox}} \left(\frac{q\Psi}{kT} + \frac{n_i^2}{N_A^2} e^{q(\Psi_S - V)/kT}\right)^{0.5}$$
(3)

For loops are used in the code to evaluate the integral as an approximate sum. From equation 3, the value of  $\Psi_S$  is calculated by substituting the other variables and interpolating for the given  $V_{GS}$ . Equation 2 is then substituted in equation 1 to evaluate the integral.

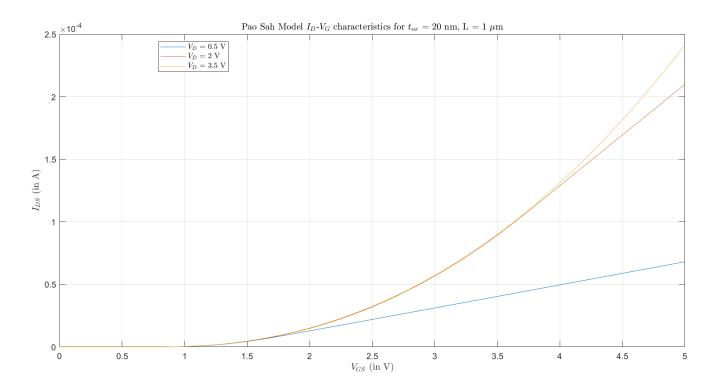


Figure 7: Case 1:  $I_D - V_D$  characteristics for Pao-Sah model

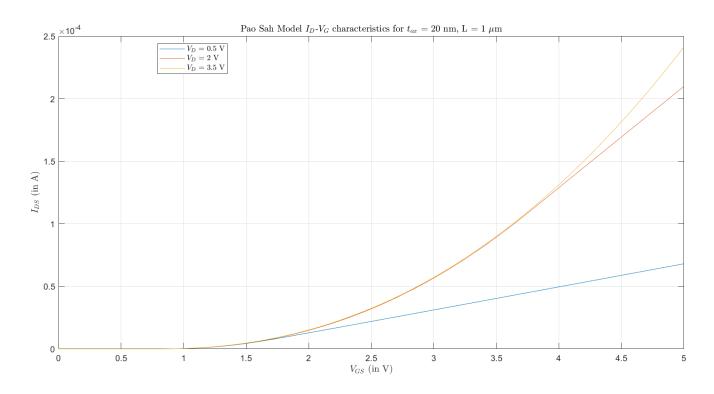


Figure 8: Case 1:  $I_D - V_G$  characteristics for Pao-Sah model

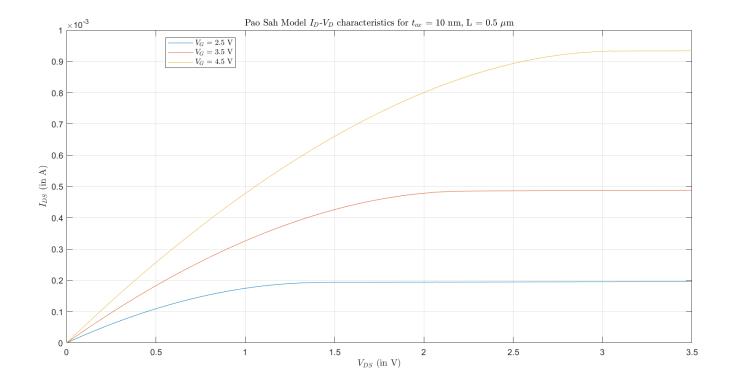


Figure 9: Case 2:  ${\cal I}_D - {\cal V}_D$  characteristics for Pao-Sah model

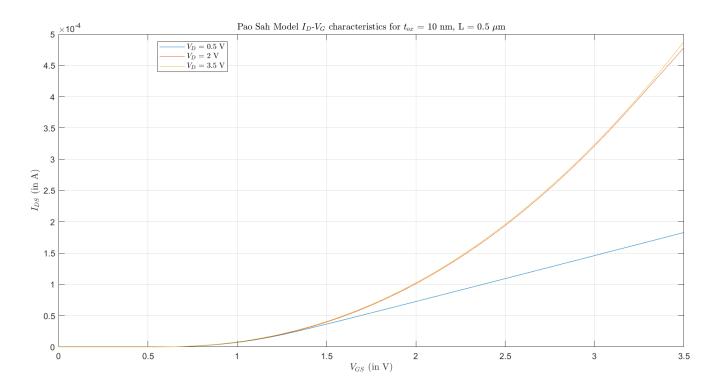


Figure 10: Case 2:  $I_D - V_G$  characteristics for Pao-Sah model

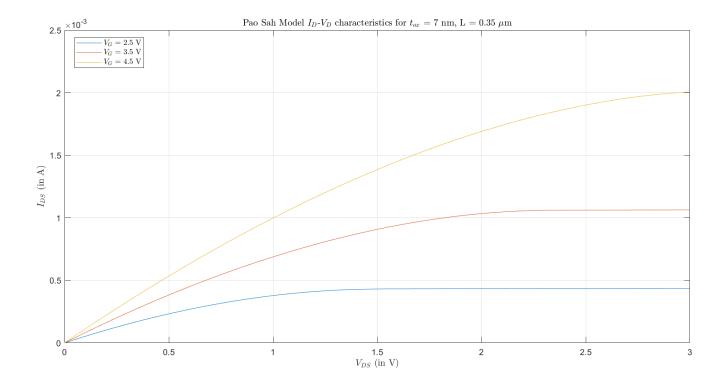


Figure 11: Case 3:  ${\cal I}_D - {\cal V}_D$  characteristics for Pao-Sah model

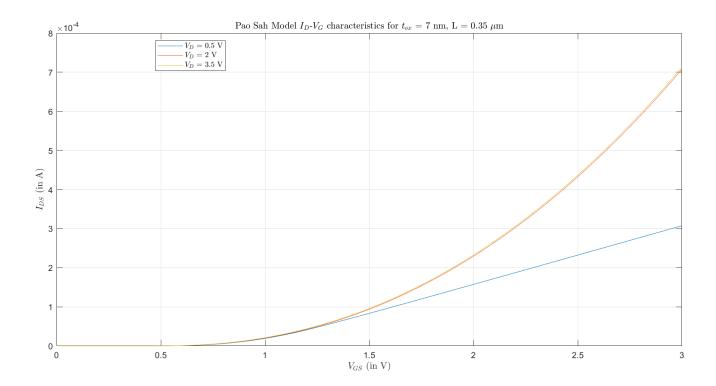


Figure 12: Case 3:  ${\cal I}_D - {\cal V}_G$  characteristics for Pao-Sah model

# **Brews Model**

Equation 3 from above is used to calculated  $\Psi_{SS}$  and  $\Psi_{SD}$ , with V as 0 and  $V_{DS}$  for the two cases respectively.

$$I_{D} = \mu \left(\frac{W}{L}\right) \int_{\Psi_{SS}}^{\Psi_{SD}} C_{ox} \left(V_{GS} - V_{FB} - \Psi_{S}\right) - \sqrt{2\epsilon_{Si}qN_{A}\Psi_{S}} + \frac{2kT}{q} \frac{C_{ox}^{2} \left(V_{GS} - V_{FB} - \Psi_{S}\right) + \epsilon_{Si}qN_{A}}{C_{ox} \left(V_{GS} - V_{FB} - \Psi_{S}\right) + \sqrt{2\epsilon_{Si}qN_{A}\Psi_{S}}} d\Psi_{S}$$
(4)

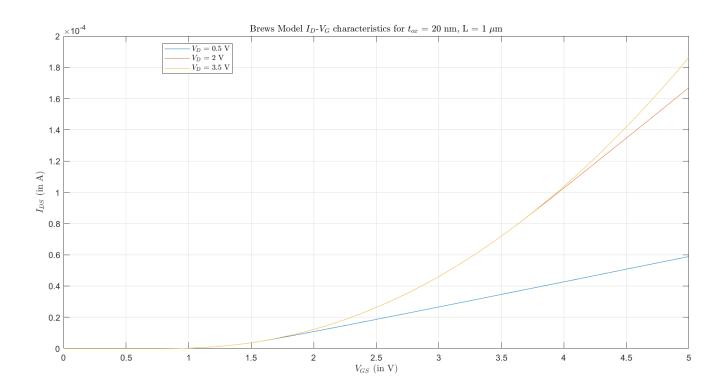


Figure 13: Case 1:  $I_D - V_D$  characteristics for Brews model

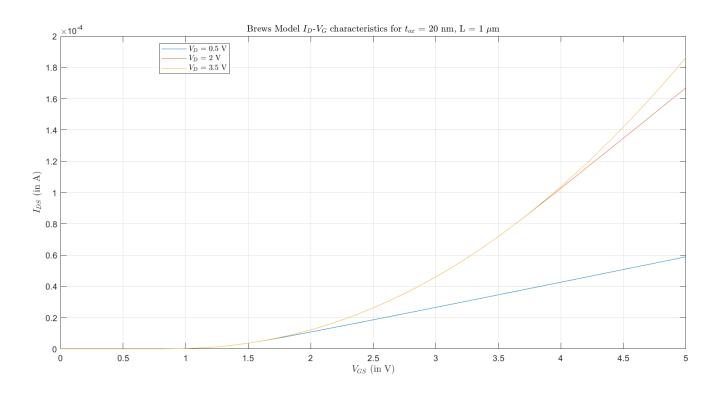


Figure 14: Case 1:  $I_D - V_G$  characteristics for Brews model

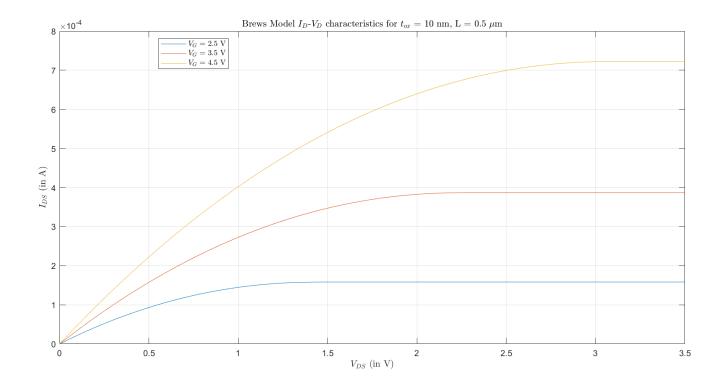


Figure 15: Case 2:  $I_D - V_D$  characteristics for Brews model

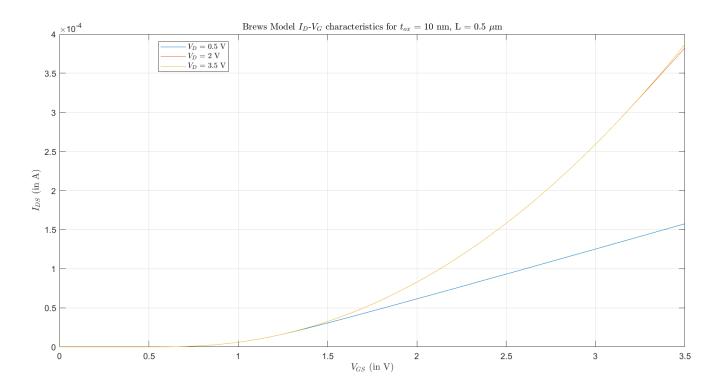


Figure 16: Case 2:  $I_D - V_G$  characteristics for Brews model

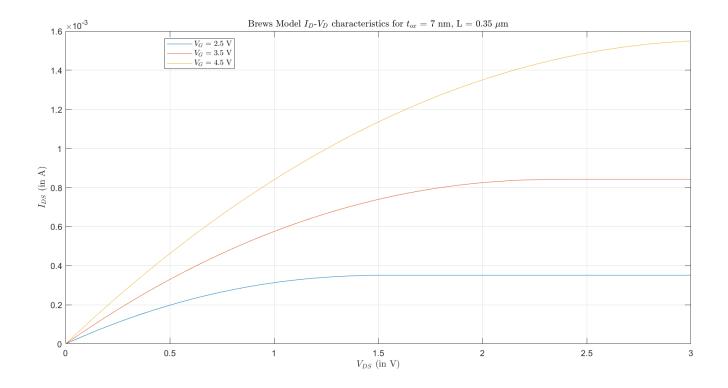


Figure 17: Case 3:  $I_D - V_D$  characteristics for Brews model

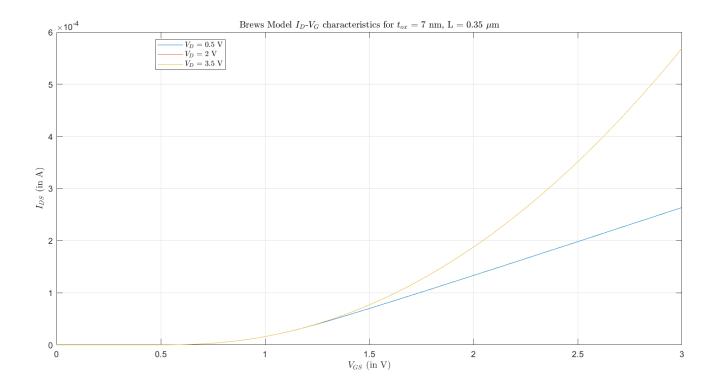


Figure 18: Case 3:  $I_D - V_G$  characteristics for Brews model